

● General Description

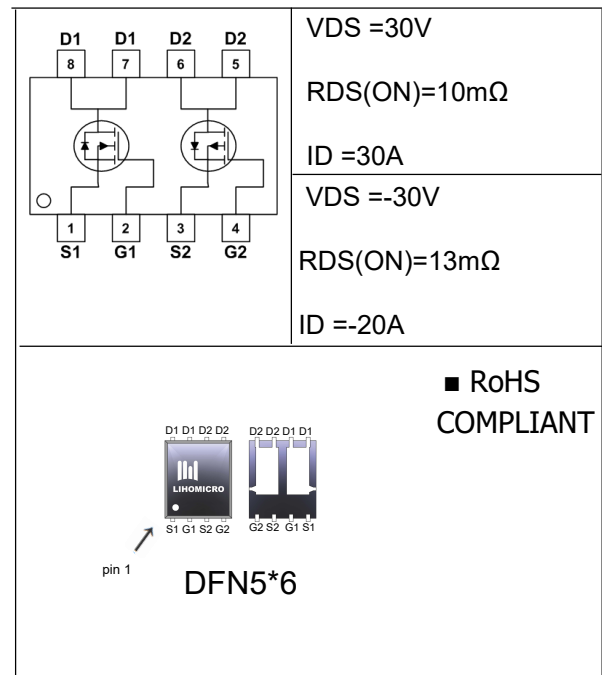
The N-ch and P-ch MOSFET LH4612 has the low $R_{DS(on)}$, low gate charge, fast switching and excellent avalanche characteristics. This device is suitable for fast charge and lighting.

● Features

- Low $R_{DS(on)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

● Application

- Lighting
- POL Application
- Wireless Charging


● Ordering Information:

Part number	LH4612
Package	DFN5*6
Basic ordering unit (pcs)	5000
Normal Package Material Ordering Code	LH4612N-DFN5*6-TAP
Halogen Free Ordering Code	LH4612N-DFN5*6-TAP-HF

● Absolute Maximum Ratings ($T_c = 25^\circ C$)

Parameter	Symbol	Rating		Unit
		N-Channel	P-Channel	
Drain-Source Voltage	V_{DS}	30	-30	V
Gate-Source Voltage	V_{GS}	± 20	± 20	V
Continuous Drain Current($T_C = 25^\circ C$) ¹	$I_{D@T_C=25^\circ C}$	30	-20	A
Pulsed Drain Current ²	I_{DM}	35	-35	A
Total Power Dissipation($T_C = 25^\circ C$) ⁴	$P_{D@T_A=25^\circ C}$	0.65	2.0	W
Avalanche Current	I_{AS}	12	-12	A
Operating Junction Temperature	T_J	-55 to 150	-55 to 150	$^\circ C$
Storage Temperature	T_{STG}	-55 to 150	-55 to 150	$^\circ C$
Single Pulse Avalanche Energy ³	E_{AS}	20	19	mJ

•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R_{thJC}	-	-	5	°C/W
Thermal resistance, junction - ambient	R_{thJA}	-	-	62.5	°C/W
Soldering temperature, wavesoldering for 10s	T_{sold}	-	-	265	°C

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	30	-	-	V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	1.0	-	2.5	V
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=\pm 30V, V_{GS}=0V, T_J=25^\circ C$	-	-	± 1.0	μA
Gate- Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	± 100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=15A$	-	10	13	m Ω
		$V_{GS}=4.5V, I_D=10A$	-	14	18	m Ω
Forward Transconductance	g_{FS}		-	10	-	S

•Electronic Characteristics($T_J = 25^\circ C$)

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Input capacitance	C_{iss}	$V_{DS}=25V,$ $V_{GS}=0V$ $f = 1MHz$	-	730	-	pF
Output capacitance	C_{oss}		-	90	-	
Reverse transfer capacitance	C_{rss}		-	29	-	
Total gate charge	Q_g	$V_{DS}=15V$ $I_D = 10A$ $V_{GS} = 4.5V$	-	8.9	-	nC
Gate - Source charge	Q_{gs}		-	4.4	-	
Gate - Drain charge	Q_{gd}		-	3.2	-	
Turn-on Delay Time	$T_d(on)$	$V_{DS}=25V$ $I_D = 6A$ $V_{GS} = 10V$	-	13	-	nS
Turn-off Delay Time	$T_d(off)$		-	30	-	
Rise Time	T_r		-	9.0	-	
Fall Time	T_f		-	7.0	-	
Gate Resistance	R_g	$V_{DS}=0V, V_{GS}=0V f = 1MHz$	-	0.9	-	Ω

● Diode Characteristics

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Continuous Source Current ^{1,5}	I _S	V _G =V _D =0V Force Current	-	-	30	A
Pulsed Source Current ^{2,5}	I _{SM}		-	-	35	A
Diode Forward Voltage ²	V _{SD}	V _{GS} =0V, I _S =1A, T _J =25°C	-	-	1.2	V

Note :

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper,t<10sec.
- 2.The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%
- 3.The EAS data shows Max. rating . The test condition is V_{DD}=25V,V_{GS}=10V,L=0.1mH,I_{AS}=10A
- 4.The power dissipation is limited by 150°C junction temperature
- 5.The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

•P-Ch Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R_{thJC}	-	-	5	°C/W
Thermal resistance, junction - ambient	R_{thJA}	-	-	62.5	°C/W
Soldering temperature, wavesoldering for 10s	T_{sold}	-	-	265	°C

•P-Ch Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=-250\mu A$	-30	-	-	V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS}=V_{DS}, I_D=-250\mu A$	-1.0	-	-2.5	V
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=\pm 30V, V_{GS}=0V, T_J=25^\circ C$	-	-	± 1.0	μA
Gate- Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	± 100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS}=-10V, I_D=-9A$	-	13	17	m Ω
		$V_{GS}=-4.5V, I_D=-6A$	-	20	25	m Ω
Forward Transconductance	g_{FS}		-	10	-	S

•P-Ch Electronic Characteristics($T_J = 25^\circ C$)

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Input capacitance	C_{iss}	$V_{DS}=-15V,$ $V_{GS}=0V$ $f = 1MHz$	-	887	-	pF
Output capacitance	C_{oss}		-	164	-	
Reverse transfer capacitance	C_{rss}		-	133	-	
Total gate charge	Q_g	$V_{DS}=-15V$ $I_D = -10A$ $V_{GS} = -4.5V$	-	32	-	nC
Gate - Source charge	Q_{gs}		-	5.4	-	
Gate - Drain charge	Q_{gd}		-	5.2	-	
Turn-on Delay Time	$T_d(on)$	$V_{DS}=-25V$ $I_D = -6A$ $V_{GS} = -10V$	-	33	-	nS
Turn-off Delay Time	$T_d(off)$		-	108	-	
Rise Time	T_r		-	18	-	
Fall Time	T_f		-	24.4	-	
Gate Resistance	R_g	$V_{DS}=0V, V_{GS}=0V f = 1MHz$	-	0.9	-	Ω

●P-Ch Diode Characteristics

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Continuous Source Current ^{1,5}	I _S	V _G =V _D =0V Force Current	-	-	-30	A
Pulsed Source Current ^{2,5}	I _{SM}		-	-	-35	A
Diode Forward Voltage ²	V _{SD}	V _{GS} =0V, I _S =-1A, T _j =25°C	-	-	-1.2	V

Note :

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper,t<10sec.
- 2.The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%
- 3.The EAS data shows Max. rating . The test condition is V_{DD}=25V,V_{GS}=10V,L=0.1mH,I_{AS}=10A
- 4.The power dissipation is limited by 150°C junction temperature
- 5.The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

● **N-Channel Typical Characteristics**

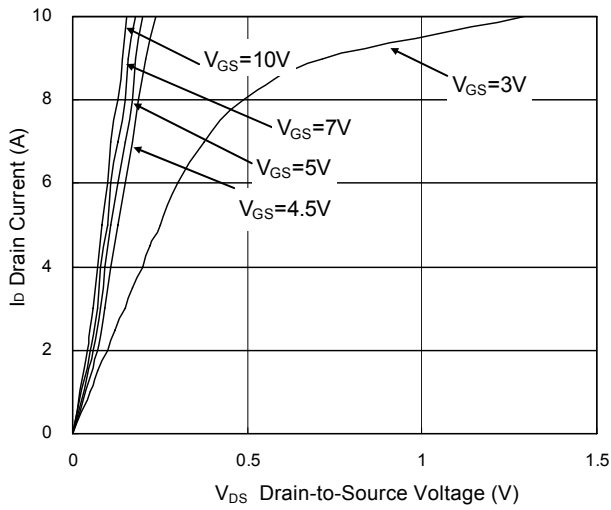


Fig.1 Typical Output Characteristics

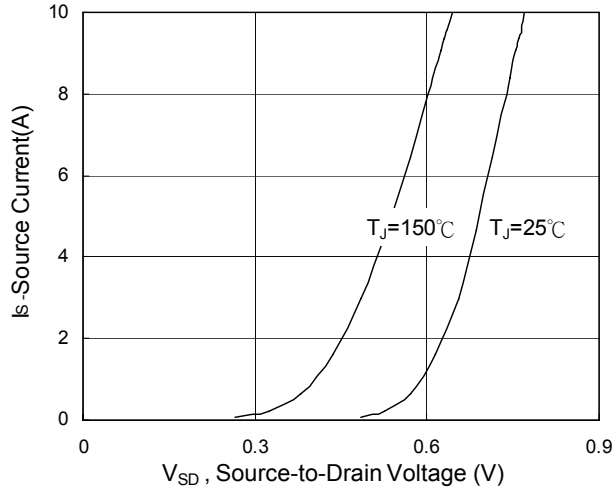
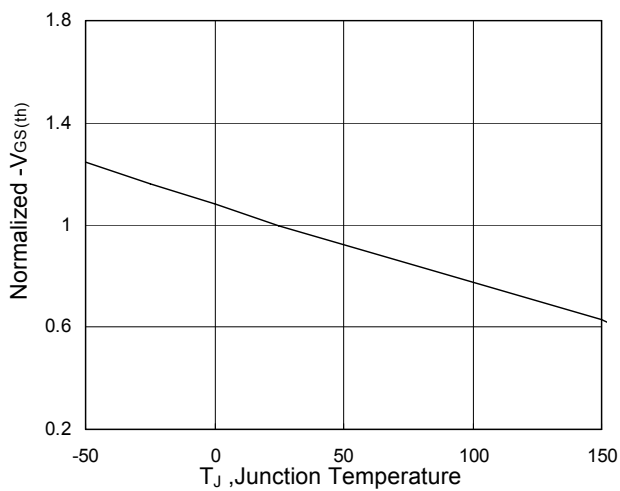


Fig.3 Forward Characteristics of Reverse



(°C) **Fig.5 $V_{GS(th)}$ vs. T_J**

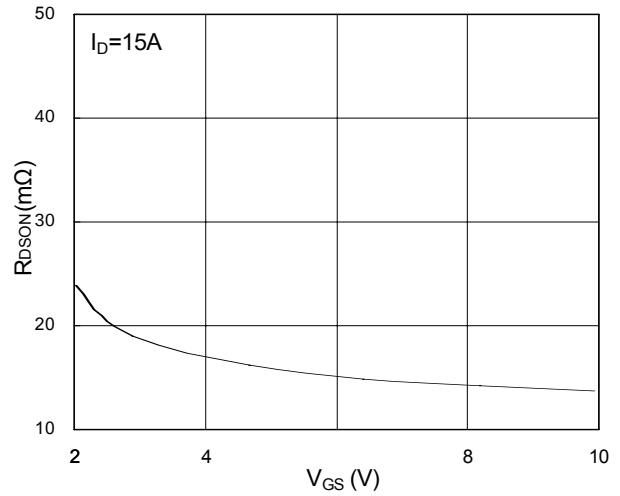


Fig.2 On-Resistance vs. G-S Voltage

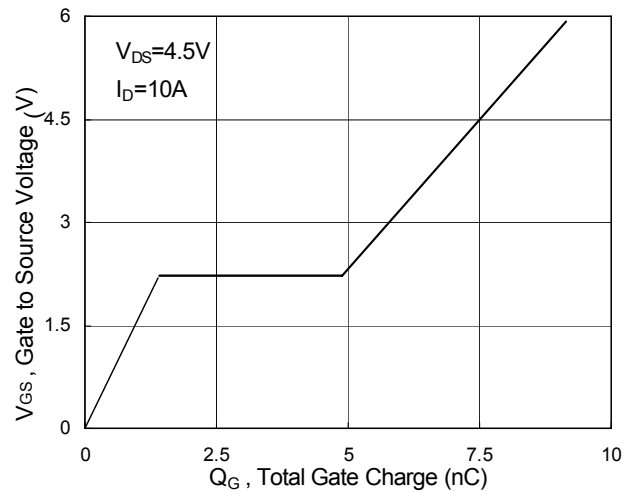


Fig.4 Gate-charge Characteristics

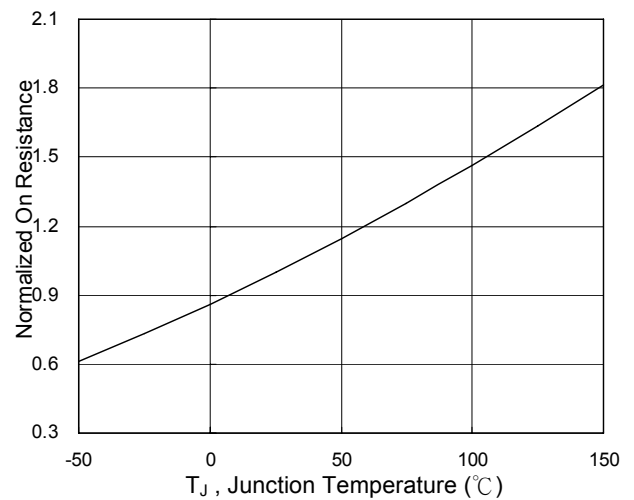


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

● **N-Channel Typical Characteristics(Cont.)**

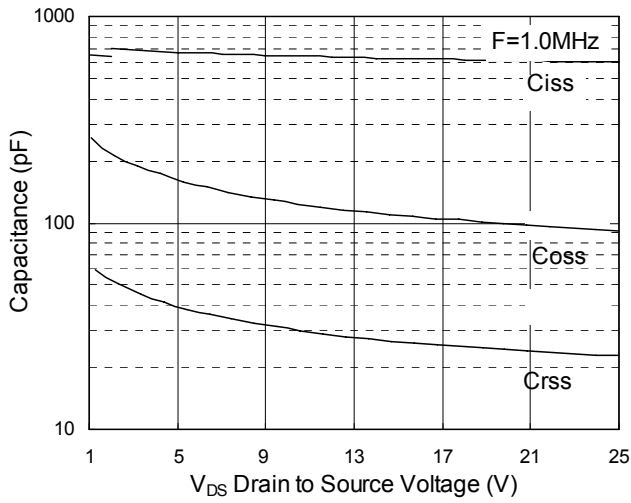


Fig.7 Capacitance

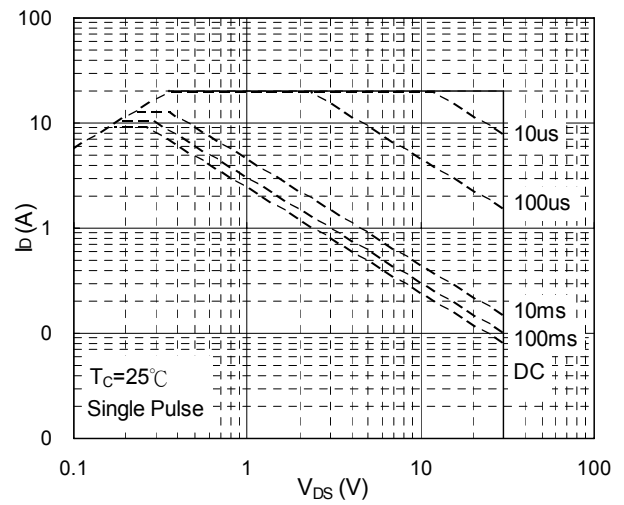


Fig.8 Safe Operating Area

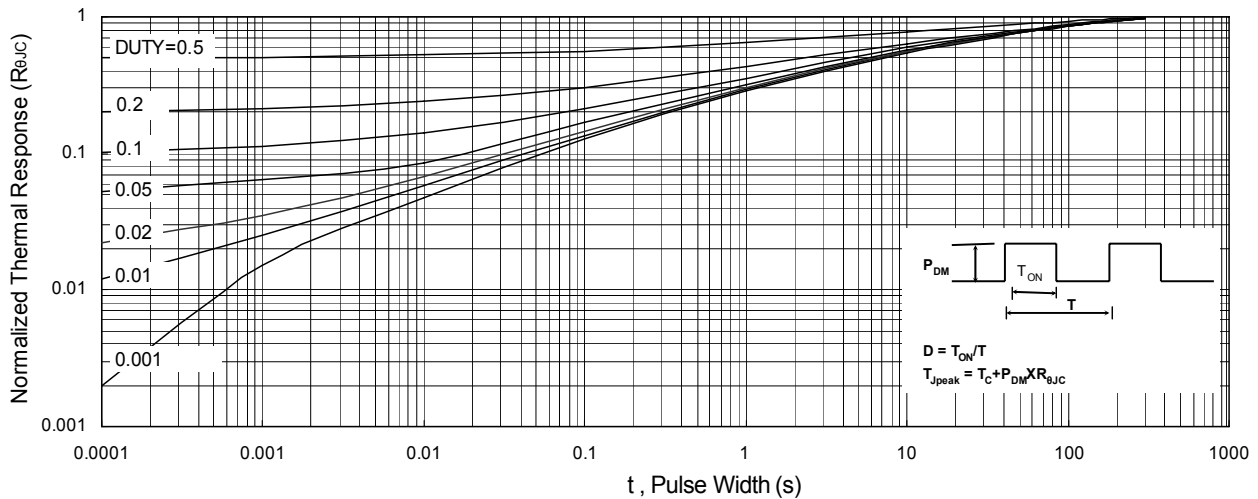


Fig.9 Normalized Maximum Transient Thermal Impedance

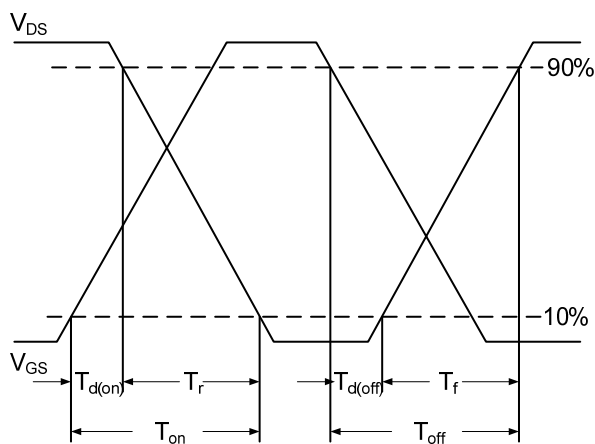


Fig.10 Switching Time Waveform

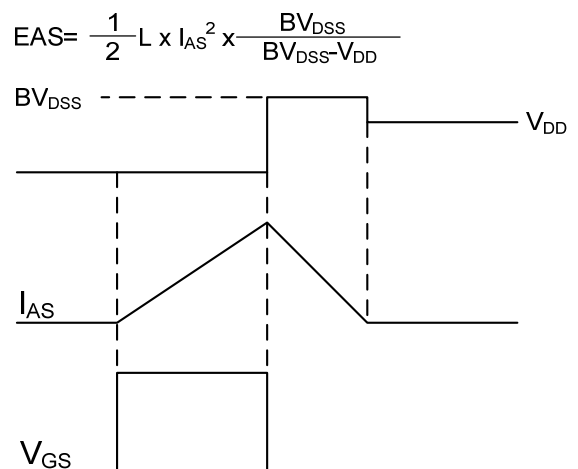


Fig.11 Unclamped Inductive Waveform

● **P-Channel Typical Characteristics**

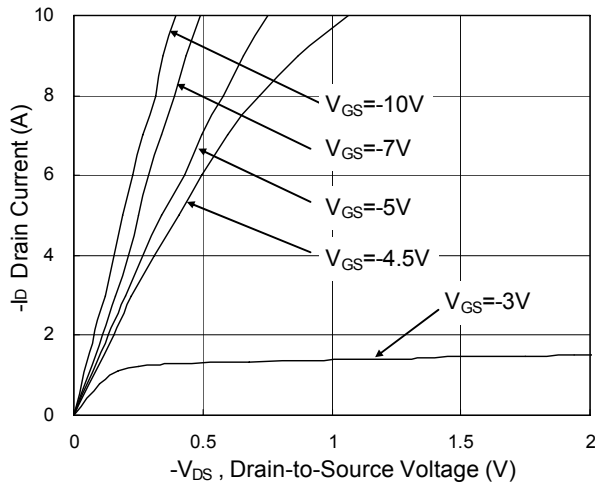


Fig.1 Typical Output Characteristics

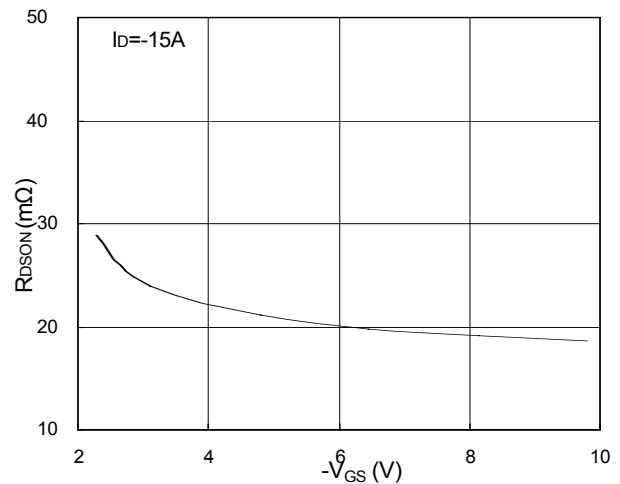


Fig.2 On-Resistance vs. Gate-Source

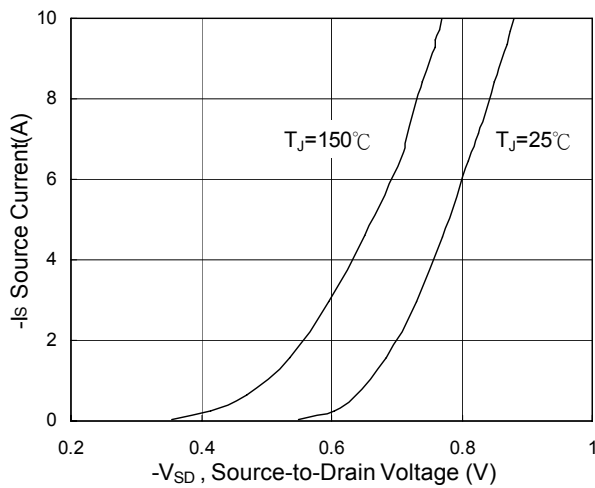


Fig.3 Forward Characteristics of Reverse

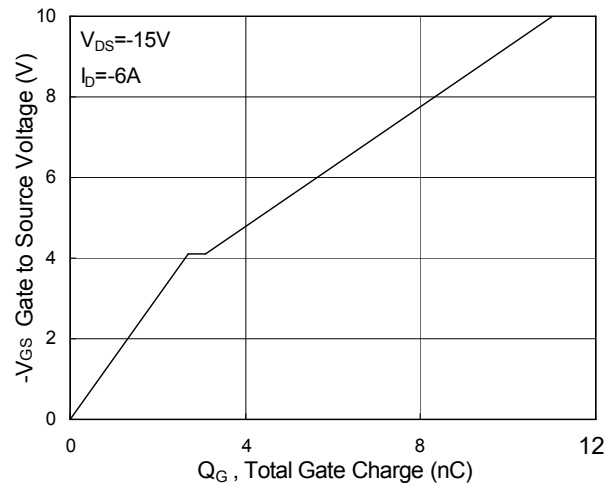


Fig.4 Gate-charge Characteristics

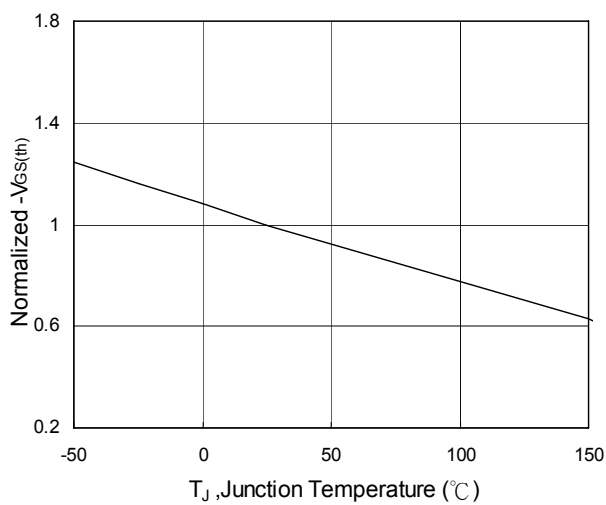


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

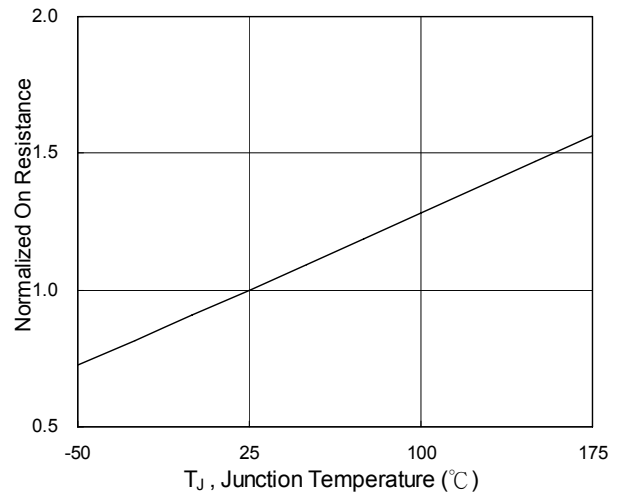


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

● **P-Channel Typical Characteristics(cont.)**

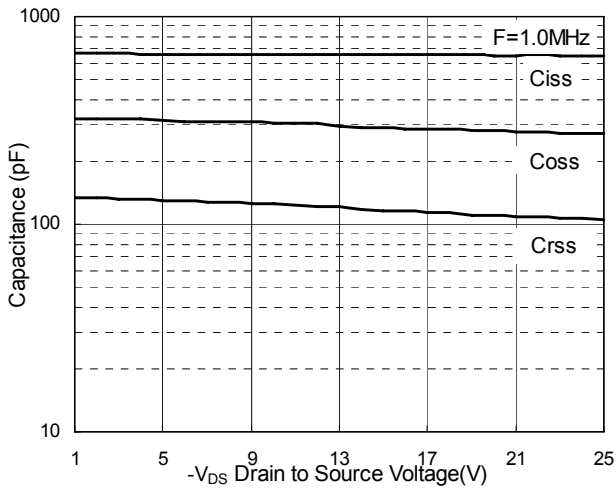


Fig.7 Capacitance

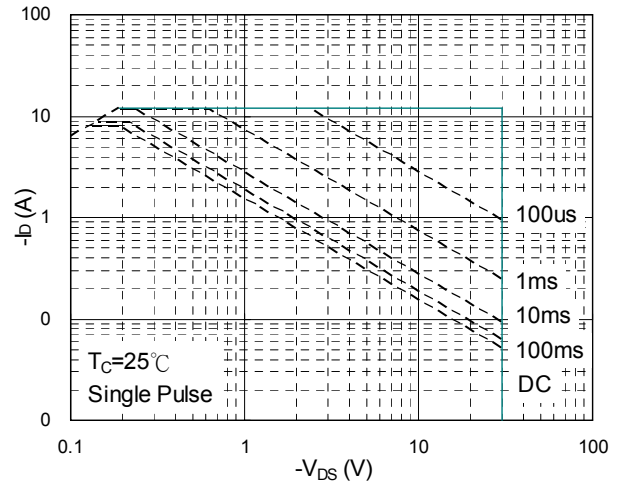


Fig.8 Safe Operating Area

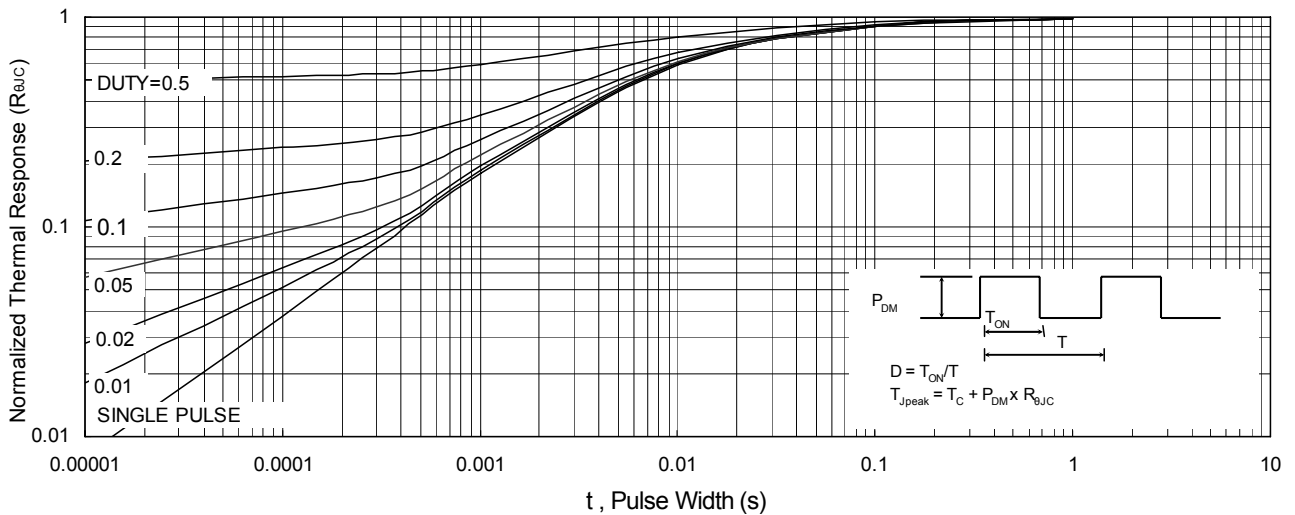


Fig.9 Normalized Maximum Transient Thermal Impedance

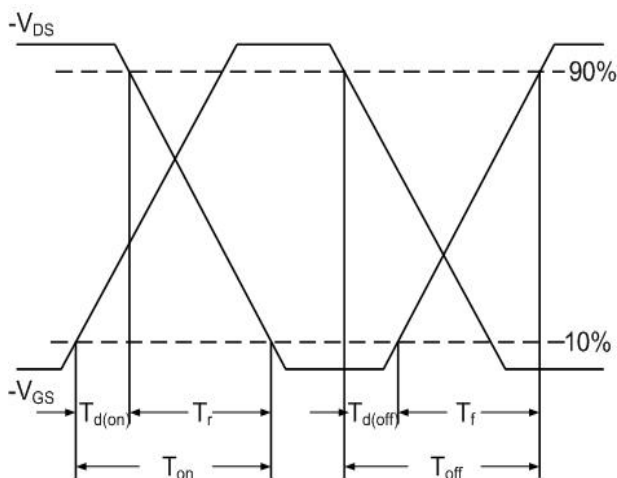


Fig.10 Switching Time Waveform

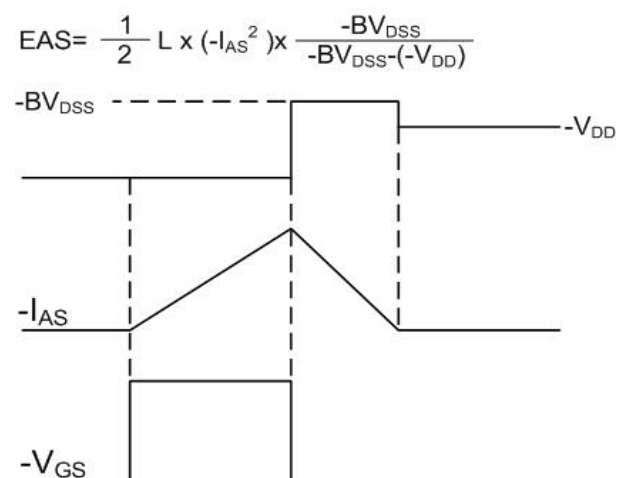


Fig.11 Unclamped Inductive Waveform

●Dimensions (DFN5*6)

Unit: mm

SYMBOL	min	max	SYMBOL	min	max
A	1.00	1.20	E1	5.90	6.40
b	0.30	0.50	e	1.27BSC	
c	0.20	0.30	L	0.05	0.30
D	4.80	5.20	L1	0.40	0.80
D1	3.90	4.30	L2	1.20	2.00
D2	1.50	1.90	H	3.30	3.80
D3	0.40	0.80	I	—	0.18
E	5.50	5.90			

